

Notice of References Cited	Application/Control No. 10/635,489	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner DAVID VU	Art Unit 2818	Page 1 of 1

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	C	US-6,563,133	05-2003	Tong, Qin-Yi	257/52
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NON-PATENT DOCUMENTS

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